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U.S. UTILITY Patent Application

APPL NUM 10008392	FILING DATE 11/13/2001	CLASS 374	SUBCLASS 045	GAU 2859	EXAMINER DE JESUS
**APPLICANTS: Paviidis Ioannis;					
**CONTINUING DATA VERIFIED: THIS APPLN CLAIMS BENEFIT OF 60/285,004 04/19/2001					
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** FOREIGN APPLICATIONS VERIFIED:					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>			
Foreign priority claimed <input type="checkbox"/> yes <input type="checkbox"/> no		ATTORNEY DOCKET NO.			
35 USC 119 conditions met <input type="checkbox"/> yes <input type="checkbox"/> no		H0002443-01			
Verified and Acknowledged Examiners's initials					
TITLE : System and method using thermal image analysis for polygraph testing					
<small>U.S. DEPT. OF COMM./PAT. & TM.-PTO-435L (Rev. 12-94)</small>					
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NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Assistant Examiner	
ISSUE FEE		Total Claims	
Amount Due	Date Paid	Print Claim for O.G.	
		DRAWING	
		Sheets Drwg.	Figs. Drwg.
		Print Fig.	
		Application Examiner	
<input type="checkbox"/> TERMINAL DISCLAIMER		PREPARED FOR ISSUE	
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